In the Claims:

This listing of claims replaces all prior versions, and listings, of claims in the application.

- 1. (Currently Amended) A heat-resistant resin laminate film comprising a heat-resistant insulating film, and [[a]] at least one heat-resistant resin layer(s) layer laminated on at least one surface of said heat-resistant insulating film, said heat-resistant resin layer having a coefficient of linear expansion kA (ppm/°C) within the range of k-10 kA k+20, [[(]] wherein k represents the coefficient of linear expansion of said heat-resistant insulating film[[)]].
- 2. (Currently Amended) The heat-resistant resin laminate film according to claim 1, comprising a heat-resistant insulating film, and a heat-resistant resin layer(s) laminated on at-least one surface of said heat-resistant insulating film, wherein said heat-resistant resin layer comprises not less than two heat-resistant resin layers at least one of which has a coefficient of linear expansion kA (ppm/°C) within the range of k-10≤kA≤k+20 (wherein k represents the coefficient of linear expansion of said heat-resistant insulating film).
- 3. (Currently Amended) The heat-resistant resin laminate film according to claim 1-or 2, wherein said heat-resistant insulating film has a coefficient of linear expansion of 5 to 25 ppm/°C, and said heat-resistant resin layer having the coefficient of linear expansion kA (ppm/°C) within the range of k-10≤kA≤k+20 (wherein k represents-the coefficient of linear expansion of said heat-resistant insulating film) has a coefficient of linear expansion of 5 to 30 ppm/°C.
- 4. (Currently Amended) The heat-resistant resin laminate film according toany one of claims 1 to 3 claim 1, wherein the resin constituting said heat-resistant resin layer having the coefficient of linear expansion kA (ppm/°C) within the range of k-10 \(\) kA \(\) (wherein k represents the coefficient of linear expansion of said heat-

resistant insulating film) is a polyimide resin comprising as a diamine component(s) component at least one aromatic diamine represented by any of the Formulae (1) to (3) in an amount of not less than 40 mol% based on the total diamine component(s).

component:

$$R_1$$
 R_2 R_3 R_4 R_4 R_2 R_4

$$R_{1}$$
 R_{2}
 R_{3}
 R_{4}
 R_{5}
 R_{6}
 R_{6}
 R_{1}
 R_{2}
 R_{4}
 R_{5}
 R_{7}
 R_{8}
 R_{8}
 R_{1}
 R_{2}
 R_{3}
 R_{4}
 R_{5}
 R_{7}

$$\begin{array}{c|c}
R_1 & R_5 \\
R_5 & R_6 \\
R_4 & R_7
\end{array}$$
(3)

[[(]]wherein R^1 to R^8 [[,]] <u>are</u> the same or different[[,]] <u>and</u> are selected from the group consisting of hydrogen, C_1 - C_{30} alkyl, C_1 - C_{30} alkoxy, halogen, hydroxy, carboxyl, sulfonic, nitro and cyano[[)]].

5. (Currently Amended) The heat-resistant resin laminate film according to claim 4, wherein said diamine component(s) component of said polyimide resin comprises at least one selected from the group consisting of *p*-phenylenediamine, 4,4'-diaminobenzanilide and 2,2'-dimethylbenzidine, in an amount of not less than 40 mol%

based on the total diamine component(s) component.

- 6. (Currently Amended) The heat-resistant resin laminate film according to claim 4, wherein a tetracarboxylic acid component(s) component of said polyimide resin comprise comprises pyromellitic dianhydride and/or biphenyltetracarboxylic dianhydride in an amount of not less than 40 mol% based on the total tetracarboxylic acid component(s) component.
- 7. (Currently Amended) A laminate film having a metal layer(s) layer, comprising said heat-resistant resin laminate film according to any one of claims 1 to 6 claim 1, and a metal layer(s) layer laminated on said heat-resistant resin layer(s) layer.
- 8. (Currently Amended) The laminate film having a metal layer(s) layer according to claim 7, comprising said heat-resistant insulating film and said metal layer(s) laminated on at least one surface of said heat-resistant insulating film through said heat-resistant resin layer, wherein said heat-resistant resin layer comprises at least two layers including said heat-resistant resin layer A whose coefficient of linear expansion kA (ppm/°C) is within the range of k-10≤kA≤k+20, [[(]]wherein k represents the coefficient of linear expansion of said heat-resistant insulating film[[)]], and a heat-resistant resin layer B having a glass transition temperature lower than that of said heat-resistant resin layer A, said heat-resistant resin layer A being laminated at a side so as to contact said metal layer, and said heat-resistant resin layer B being laminated at a side so as to contact said heat-resistant insulating film.
- 9. (Original) The laminate film having a metal layer(s) according to claim 8, wherein said heat-resistant resin layer A has a glass transition temperature of 250°C to 400°C.
- 10. (Currently Amended) The laminate film having a metal layer(s) layer according to claim 8-or-9, wherein said heat-resistant resin layer A has a thickness of not less than twice that of said heat-resistant resin layer B.

- 11. (Currently Amended) The laminate film having a metal layer(s) layer according to any one of claims 8 to 10 claim 8, wherein said heat-resistant resin layer B consists essentially of [[a]] polyimide resin(s) resin.
- 12. (Original) The laminate film having a metal layer(s) according to claim 11, wherein said heat-resistant resin layer B has a glass transition temperature of 120°C to 280°C.
- 13. (Currently Amended) The laminate film having a metal layer(s) layer according to any one of claims 8 to 10 claim 8, wherein said heat-resistant resin layer B consists essentially of a thermosetting resin(s) resin containing an epoxy compound(s) compound.
- 14. (Currently Amended) The laminate film having a metal layer(s) layer according to claim 13, wherein said heat-resistant resin layer B has a glass transition temperature of 50°C to 250°C.
- 15. (Currently Amended) A semiconductor device comprising said laminate film having a metal layer(s) layer according to any one of claims 6 to 14 claim 6.
- 16. (Currently Amended) A process of producing a laminate film having a metal layer(s) layer comprising a heat-resistant insulating film and a metal layer(s) layer laminated on at least one surface of said heat-resistant insulating film through a heat-resistant resin layer(s) layer(s) layer, said process comprising the steps of laminating at least one heat-resistant resin layer including a heat-resistant resin layer having a coefficient of linear expansion kA (ppm/°C) within the range of k-10≤kA≤k+20, [[(]]wherein k represents the coefficient of linear expansion of said heat-resistant insulating film,[[)]] on said metal layer; laminating the resulting metal layer/heat-resistant resin layer laminate(s) laminate and said heat-resistant insulating film which-may, as required, have at least one heat-resistant resin layer; and heat pressing the resulting laminate.

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17. (Currently amended) A process of producing a laminate film having a metal layer(s) layer comprising a heat-resistant insulating film and a metal layer(s) layer laminated on at least one surface of said heat-resistant insulating film through a heat-resistant resin layer(s) layer(s) layer, said process comprising the steps of laminating at least one heat-resistant resin layer including a heat-resistant resin layer having a coefficient of linear expansion kA (ppm/°C) within the range of k-10≤kA≤k+20½ [[(]] wherein k represents the coefficient of linear expansion of said heat-resistant insulating film½[[)]] on said heat-resistant insulating film; laminating the resulting heat-resistant insulating film/heat-resistant resin layer laminate and said metal layer(s) layer which may, as required, have at least one heat-resistant resin layer; and heat pressing the resulting laminate.